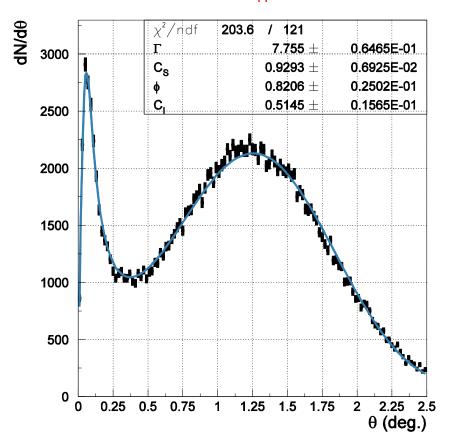
Study m_{vv} background fitting correction

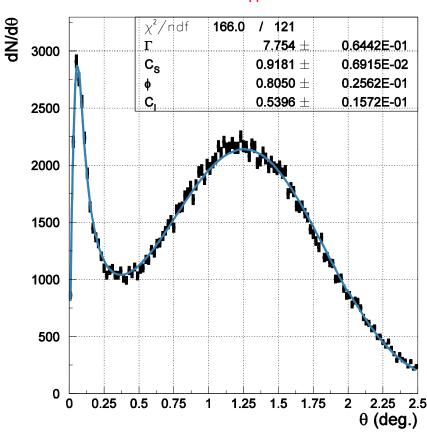
• Fit the yield of 50 MC runs

Silicon

With old background fit correction (yield from the m_{yy} fit parameter)

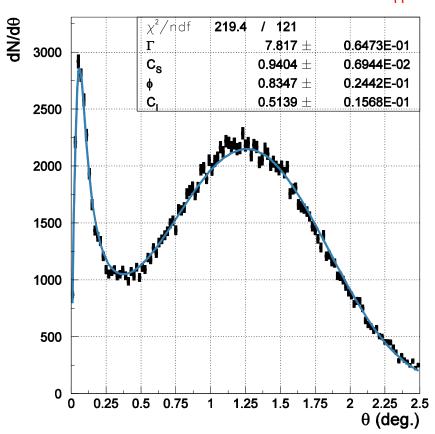


With new background fit correction (yield from the m_{yy} fit parameter)

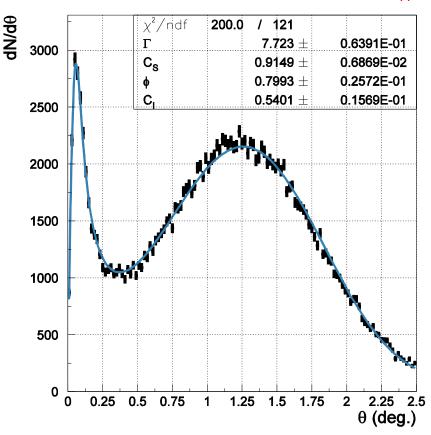


Silicon

With old background fit correction (yield from the sum of bins of m_{vv})

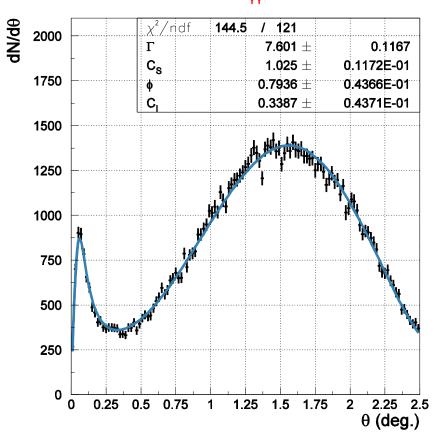


With new background fit correction (yield from the sum of bins of m_{yy})

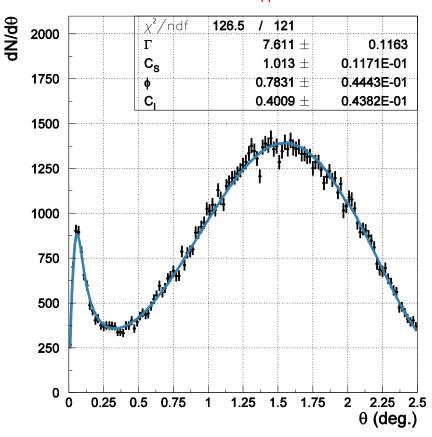


Carbon

With old background fit correction (yield from the m_{yy} fit parameter)

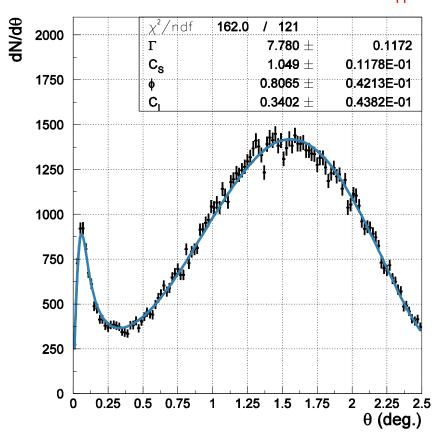


With new background fit correction (yield from the m_{yy} fit parameter)

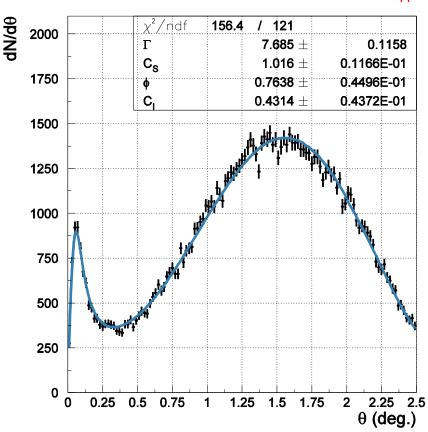


Carbon

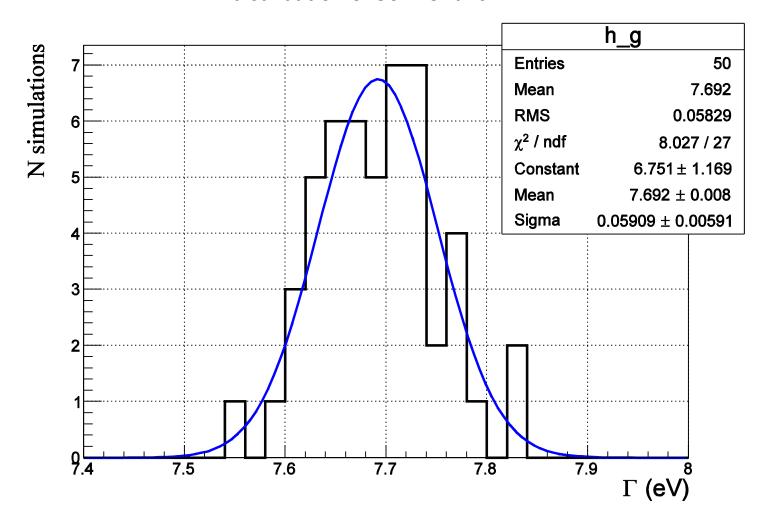
With old background fit correction (yield from the sum of bins of m_{yy})



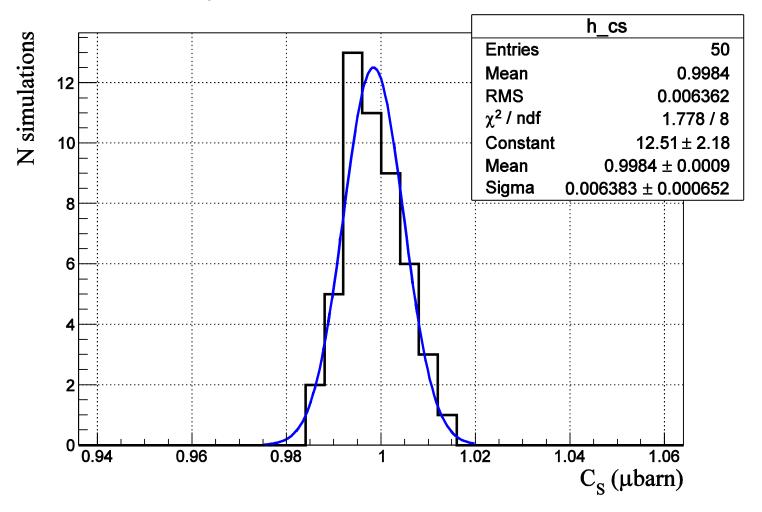
With new background fit correction (yield from the sum of bins of m_{yy})



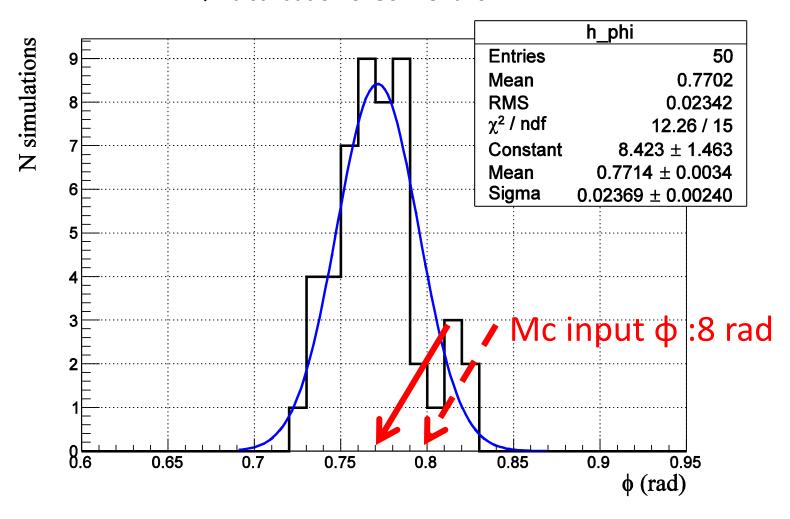
Γ distribution of 50 MC runs



C_S distribution of 50 MC runs



Φ distribution of 50 MC runs



C₁ distribution of 50 MC runs

